

University of Groningen

## Fundamental limitations of THz and Niobiumnitride SIS mixers

Dieleman, Pieter

**IMPORTANT NOTE: You are advised to consult the publisher's version (publisher's PDF) if you wish to cite from it. Please check the document version below.**

*Document Version*

Publisher's PDF, also known as Version of record

*Publication date:*

1998

[Link to publication in University of Groningen/UMCG research database](#)

*Citation for published version (APA):*

Dieleman, P. (1998). *Fundamental limitations of THz and Niobiumnitride SIS mixers*. University of Groningen.

### Copyright

Other than for strictly personal use, it is not permitted to download or to forward/distribute the text or part of it without the consent of the author(s) and/or copyright holder(s), unless the work is under an open content license (like Creative Commons).

### Take-down policy

If you believe that this document breaches copyright please contact us providing details, and we will remove access to the work immediately and investigate your claim.

*Downloaded from the University of Groningen/UMCG research database (Pure): <http://www.rug.nl/research/portal>. For technical reasons the number of authors shown on this cover page is limited to 10 maximum.*

## Appendix A

# Performing heterodyne measurements

### A.1 Junction performance testing

The standard procedure of SIS junction behavior and sensitivity testing is as follows. First, the direct response is measured with a Fourier transform spectrometer (FTS) to compare with the designed center frequency and bandwidth. An example of such a frequency spectrum is shown in Fig. 3.1 in Ch. 3. A quantitative measurement of the noise and gain contributions of the junction is obtained in a heterodyne experiment. Accurate descriptions of how SIS heterodyne measurements are performed are given in Refs. [1–3].

Fig. A.1 shows the layout of the measurement setup. In short, the LO is injected into the Dewar by a Mylar beamsplitter. Since the use of a beamsplitter implies that the injection of LO is at the expense of the transmission of the signal, the beamsplitter thickness is chosen such that the signal is attenuated as little as possible, whilst maintaining an LO power level sufficient for heterodyne mixing. The LO power level is fine-tuned by a polarizing grid. The output signal of the junction is amplified by three 1.5 GHz amplifiers with a total gain of 80 dB.

For astrophysicists the property of main importance of the receiver is its sensitivity. To allow for a comparison of the strength of the signal to be detected and the integration time needed, the sensitivity of the device is expressed in the noise generated by the device *referred to the input*. The noise power is expressed as

an equivalent temperature, the noise temperature  $T_N$ , via  $P_N = k_B T_N$ . In this way the receiver can be viewed as a noiseless amplifier with gain  $G$  and a noise generator (a black body or a matched resistor) at temperature  $T_N$ . Although the measurable parameters in the laboratory are the input and output powers, the two parameters  $G$  and  $T_N$  are easily obtained by the so called Y-factor method. In a Y-factor measurement, a hot (300 K) and a cold (77 K) black body load are applied individually to the receiver input, and the ratio,  $Y$ , of the receiver output powers is measured. The output powers are given by

$$P_{outc} = G \cdot (P_N + P_{in}(77K)) \quad (\text{A.1})$$

$$P_{outh} = G \cdot (P_N + P_{in}(300K)) \quad (\text{A.2})$$

In which  $P_{in}(T)$  is the thermal noise power which is radiated into the device by a black body at physical temperature  $T$ . The measured Y-factor is

$$Y = \frac{P_N + P_{outh}}{P_N + P_{outc}} \quad (\text{A.3})$$

The equivalent input noise power is found by inverting this equation:

$$P_N = \frac{P_{outh} - Y P_{outc}}{Y - 1} \quad (\text{A.4})$$

and the gain is obtained from the difference in output powers:

$$G = \frac{P_{outh} - P_{outc}}{P_{in}(300K) - P_{in}(77K)} \quad (\text{A.5})$$

A matter of debate is how the zero-point fluctuation noise temperature,  $hf/2k_B$  is to be taken into account in the receiver noise temperature calculation[4,5]. Since this power is always impinging on the receiver input, one could argue that this noise is an intrinsic contribution to the receiver noise temperature and should not be considered part of the signal. However, since this power is actually measurable, we take it as part of the signal rather than part of the intrinsic receiver noise. Therefore we use the complete Callen & Welton[6] equation relating the physical temperature and the radiated power:

$$P(T) = \frac{hfB}{e^{\frac{hf}{k_B T}} - 1} + \frac{hfB}{2} = hfB \coth\left(\frac{hf}{2k_B T}\right) \quad (\text{A.6})$$

in which  $f$  is the frequency,  $B$  the bandwidth, and  $h$  and  $k_B$  are the Planck and Boltzmann's constants respectively. This power is basically Planck's law with an additional "half photon" per Hz of bandwidth.

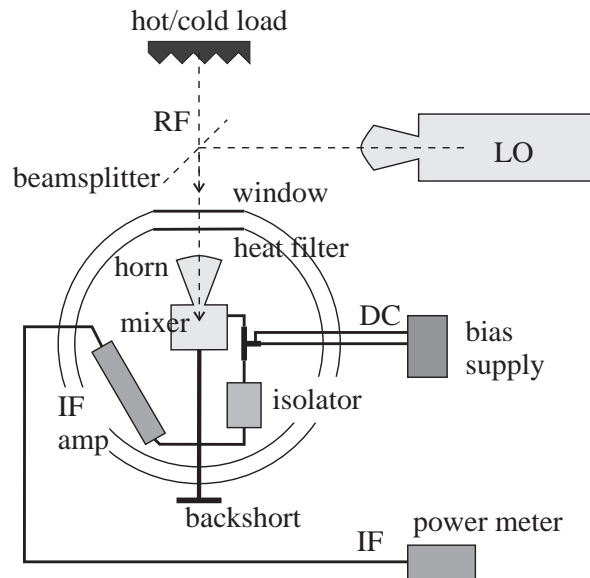


FIGURE A.1. Schematic overview of the heterodyne measurement setup. A cross-sectional view of the mixerblock is shown in Fig. 1.5, the electrical layout of the DC and IF measurement is illustrated in Fig. 6.2.

## A.2 Receiver layout

Since SIS receivers operate below 10 K, thermal shielding is necessary to maintain this low temperature without excessive He consumption. The junction is therefore placed in a Dewar with 300, 77 and 4 K compartments. Windows transparent to submm radiation are placed in the shields to couple in the LO and signal radiation. A heat filter is placed in the optical path to filter infrared radiation out of the incoming beam. A Nb coil to suppress the Josephson supercurrent leading to Shapiro steps as shown in Fig. 5.2 is mounted in front of the mixer block.

The Dewar layout taking into account these considerations is as sketched in Fig. A.1. Noise contributions and descriptions of the components in the RF and IF path are calculated in Chs. 3 and 6 respectively.

---

## References

- [1] G. de Lange, Ph.D. Thesis, University of Groningen, 1994
- [2] C.E. Honingh, Ph.D. Thesis, University of Groningen, 1993.
- [3] W.R. McGrath, P.L. Richards, D.W. Face, D.E. Prober, and F.L. Lloyd, J. Appl. Phys. **63**, 2479 (1988).
- [4] A.R. Kerr, M.J. Feldman, and S.-K Pan, *NRAO Electronics Division Internal Report No. 304*, (1996), and M.J. Feldman, *Eighth International Symposium on Space THz Technology*, Harvard Smithsonian Institute Cambridge, Mass, USA (1997).
- [5] M.J. Wengler and D.P. Woody, *IEEE Journal of Quantum Electronics* **23**, 613 (1987).
- [6] H.B. Callen and T.A. Welton, Phys. Rev. **83**, 34 (1951).